Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10519753	KOIKE ET AL.
Examiner	Art Unit
Chan lunnana	2621

SEARCHED					
Class	Subclass	Date	Examiner		
455	266,575.7	08/25/2006	J.C.		
381	3	08/25/2006	J.C.		
367	137	08/25/2006	J.C.		
330	9	08/25/2006	J.C.		
327	15	08/25/2006	J.C.		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Image and keyword search in USPAT, US-PGPub, DERWENT, EPO, JPO and IBM_TDB	08/15/2006	J.C.		
Consulted with Rafael Perez-Gutierrez, Edan Orgad	08/15/2006	J.C.		
Consulted with Fayyaz Alam	01/23/2007	J.C.		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examine		

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